Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/580,900	Reexamination VANDERMEULE	N, KRIS
Examiner	Art Unit	
DAVID BANH	2854	Page 1 of 1

II S PATENT DOCUMENTS

	U.S. PATENT DOCUMENTS				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,398,049 A	03-1995	Terasawa et al.	347/8
*	В	US-6,106,166 A	08-2000	Spurr et al.	396/578
*	С	US-6,409,401 B1	06-2002	Petteruti et al.	400/88
*	D	US-2007/0136208 A1	06-2007	Hamashima et al.	705/062
*	Е	US-2008/0094463 A1	04-2008	Tsuchida et al.	347/197
	F	US-			
	G	US-		-	
	Н	US-			
		US-			
	J	US-			
	К	US-			
	L	US-			
	м	US-			

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q		1			
	R					
	s					
	т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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